



Premstaetten, January 12, 2021

CN55-2020 – Test Location and Test Platform Change release for CMV12000 Mono

Dear Customer,

As stated in PCN04-2020, ams AG intends to release the transfer of the wafer probing as well as the final electrical test for the below products to the Teradyne IP750EX ATE test platform.

Affected part number list:

Material Part Number	Material Description
302010004	CMV12000-2E5M1PA QA
302010005	CMV12000-2E5M1PN QA

If you do have further questions, please do not hesitate to contact our customer support team at any time.

Best regards,

A handwritten signature in black ink, appearing to read 'Peter Crabbe', with a stylized flourish at the end.

Peter Crabbe
ams AG
Director Operations CIS